

## Data Sheet



# SCA3100-D04 3-AXIS HIGH PERFORMANCE ACCELEROMETER WITH DIGITAL SPI INTERFACE

## Features

- 3.3V supply voltage
- $\pm 2$  g measurement range
- 3-axis measurement XYZ directions
- $\pm 30$ mg offset stability over temp range
- SPI digital interface
- Extensive self diagnostics features
- Size 7.6 x 3.3 x 8.6 mm (w x h x l)
- Qualified according to AEC-Q100 standard
- Package, pin-out and SPI protocol compatible with Murata digital accelerometer product family
- RoHS compliant Dual Flat Lead (DFL) plastic package suitable for lead free soldering process and SMD mounting
- Proven capacitive 3D-MEMS technology

## Applications

SCA3100-D04 is targeted to applications with high stability requirements. Typical applications include

- Hill Start Aid (HSA)
- Electronic Parking Brake (EPB)
- Roll Over detection
- Suspension control
- Inclinometers
- Motion and position measurements

## General Description

SCA3100-D04 is a high performance three axis accelerometer component based on Murata capacitive 3D-MEMS technology. The component integrates high accuracy micromechanical acceleration sensing together with a flexible SPI digital interface. Dual Flat Lead (DFL) housing guarantees reliable operation over product lifetime.

SCA3100-D04 is designed, manufactured and tested for high stability, reliability and quality requirements of automotive applications. The accelerometer has extremely stable output over wide range of temperature, humidity and vibration. The component is qualified against AEC-Q100 standard and has several advanced self diagnostics features. The DFL housing is suitable for SMD mounting and the component is compatible with RoHS and ELV directives.

SCA3100-D04 is a part of Murata digital accelerometer family and fully compatible with single axis accelerometers (SCA800 series) and other multi axis accelerometers (SCA2100 series and SCA3100 series).

## Performance Characteristics

Vdd=3.3 V and ambient temperature unless otherwise specified.

| Parameter                              | Condition                             |                   |                   |                  |         |
|--|---------------------------------------|-------------------|-------------------|------------------|---------|
|  |                                       | Min               | Typ <sup>A)</sup> | Max              | Units   |
| Analog and digital Vdd                 |                                       | 3.0               |                   | 3.6              | V       |
| Current consumption                    | Active mode                           |                   | 3                 | 5                | mA      |
|  | Power down mode                       |                   | 0.12              |                  | mA      |
| Measurement range                      | Measurement axes (XYZ)                | -2                |                   | 2                | g       |
| Operating temperature                  |                                       | -40               |                   | 125              | °C      |
| Offset total error <sup>B)</sup>       | Temperature range -40 ... +125 °C     | -70               |                   | 70               | mg      |
| Offset calibration error <sup>C)</sup> | @25 °C ±5°C                           | -40               | ±16               | 40               | mg      |
| Offset temperature drift               | Temperature range -40 ... +125 °C     | -30 <sup>D)</sup> | ±18 <sup>E)</sup> | 30 <sup>D)</sup> | mg      |
| Sensitivity                            | 12 bit output                         |                   | 900               |                  | Count/g |
|  | Between ±3°                           |                   | 0.0637            |                  | %/Count |
| Total sensitivity error                | Temperature range -40 ... +125 °C     | -4                |                   | 4                | % FS    |
| Sensitivity calibration error          | @25 °C ±5°C                           |                   | ±0.5              |                  | % FS    |
| Sensitivity temperature drift          | Temperature range -40 ... +125 °C     |                   | ±0.8              |                  | % FS    |
| Linearity error                        | +1g ... -1g range                     | -20               |                   | 20               | mg      |
| Cross-Axis sensitivity                 |                                       | -3.5              | ±2.5              | +3.5             | %       |
| Zero acceleration output               | 2-complement                          |                   | 0                 |                  | Counts  |
| Amplitude response <sup>F)</sup>       | -3dB frequency                        | 30                |                   | 55               | Hz      |
| Noise                                  |                                       |                   |                   | 5                | mg RMS  |
| Power on setup time                    |                                       |                   |                   | 0.1              | s       |
| Output data rate                       |                                       |                   | 2000              |                  | Hz      |
| Output load                            |                                       |                   |                   | 50               | pF      |
| SPI clock rate                         |                                       |                   |                   | 8                | MHz     |
| ESD protection                         | Human Body Model                      |                   |                   | 2                | kV      |
|  | Charge Device Model                   |                   |                   | 1                | kV      |
| Moisture sensitivity level             | IPC/JEDEC J-STD-020C, Level 3         |                   |                   |                  |         |
| Mechanical shock                       |                                       |                   |                   | 20 000           | g       |
| ID register value                      | Customer readable ID register (27hex) |                   | C1                |                  |         |

- A) Typical ± values are ±3 sigma variation limits from validation test population.  
 B) Includes offset deviation from 0g value including calibration error and drift over lifetime, temperature and supply voltage.  
 C) Includes offset deviation from 0g value including calibration error and drift over lifetime.  
 D) Offset drift due to temperature. Value is a relative value and has been centered to zero. Error defined as maximum change of offset in temperature range. Offset (max)-Offset (Min). 100% tested in production.  
 E) Biggest change of output from RT value due temperature.  
 F) See figure 4.

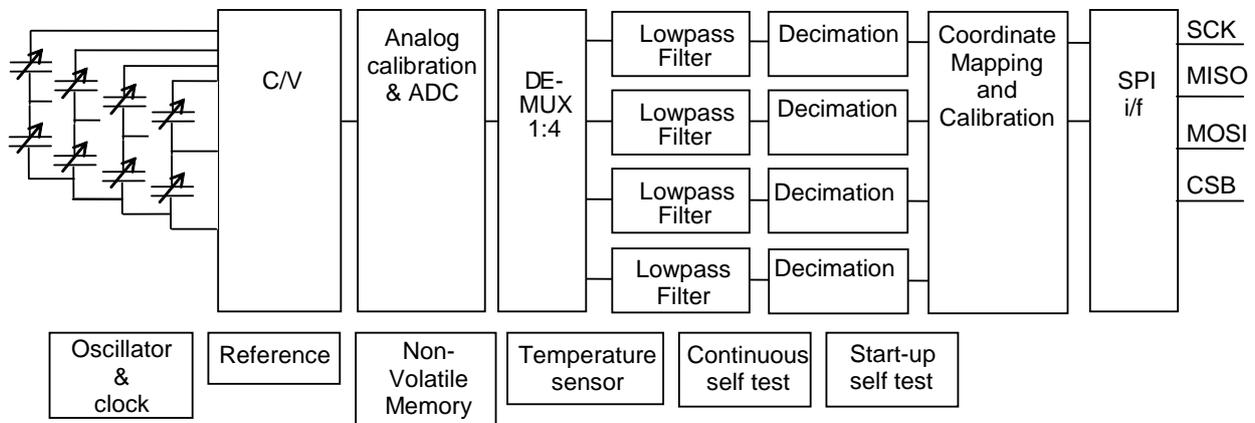
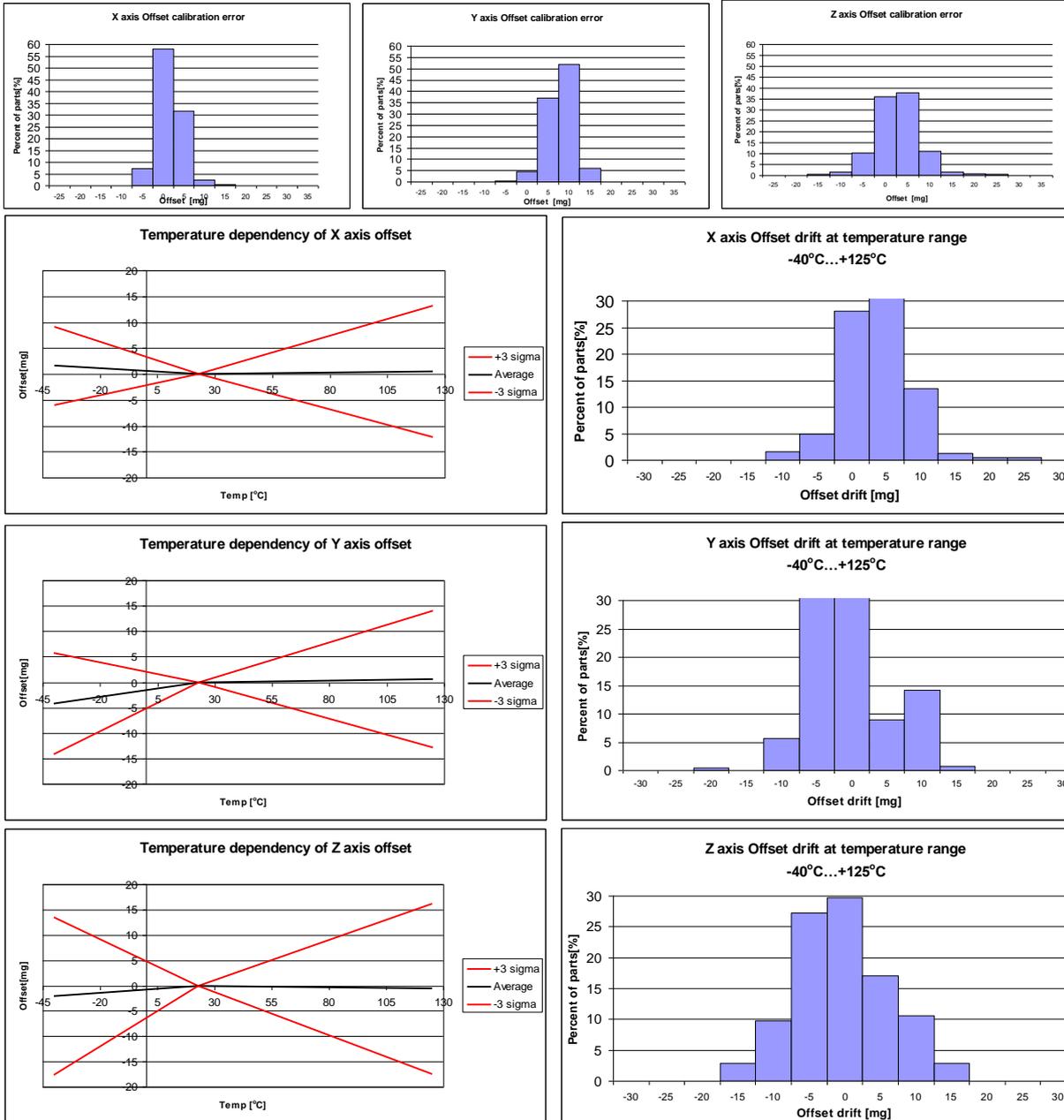
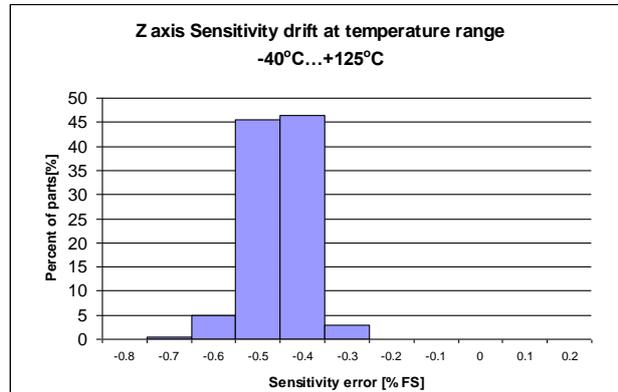
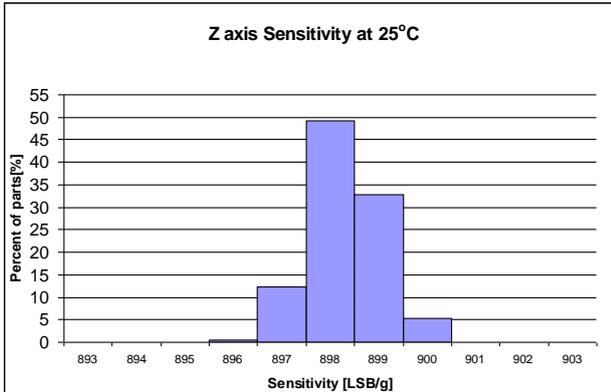
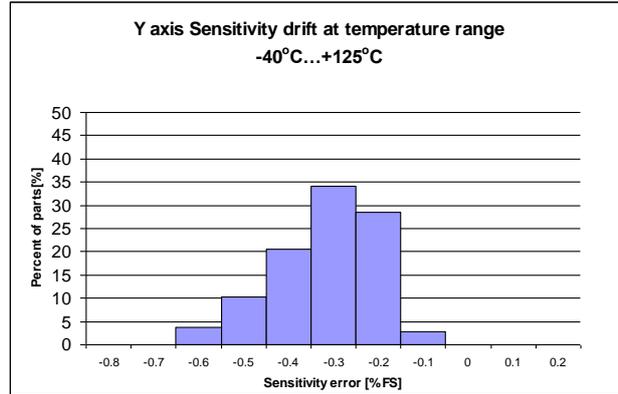
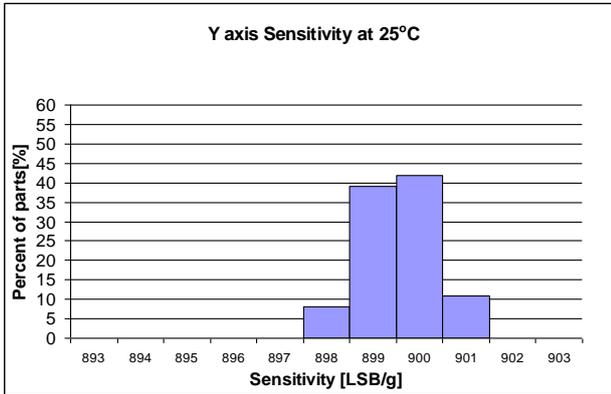
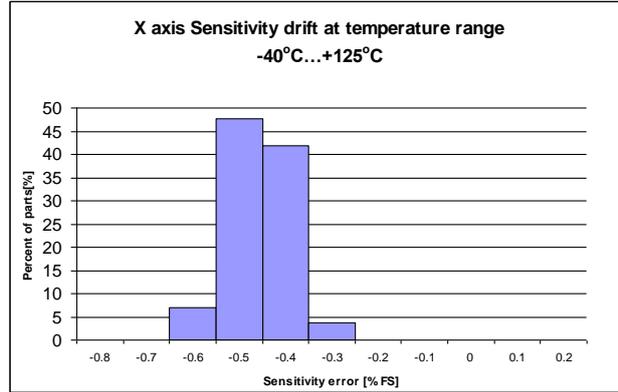
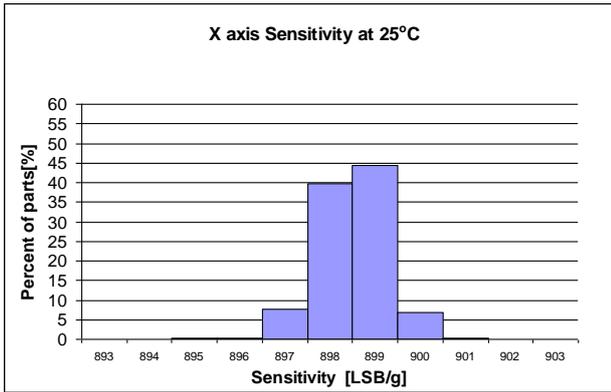


Figure 1. SCA3100-D04 Block diagram

## Typical Performance characteristics





### Measurement directions

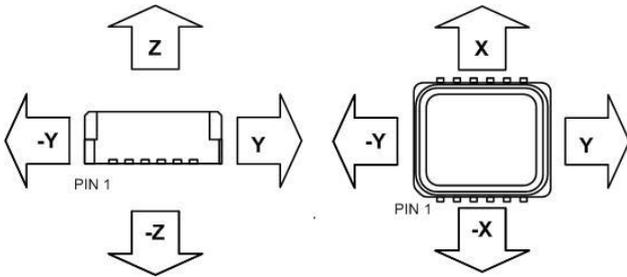


Figure 1. Accelerometer measuring directions

### Housing dimensions

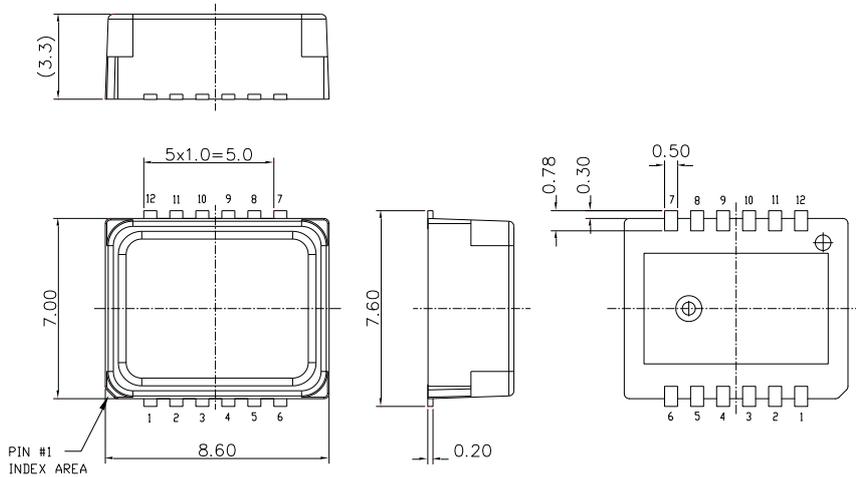


Figure 2. Housing dimensions

### Frequency response

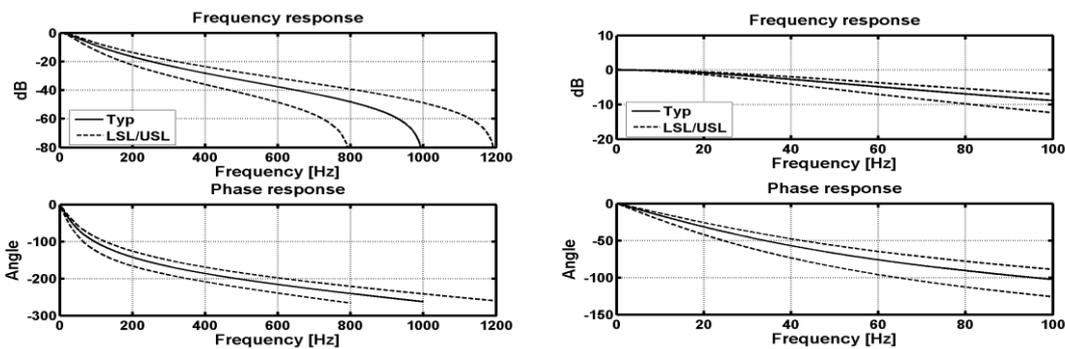


Figure 3. Frequency response curves